## Notice of References Cited

Application/Control No.

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Examiner

Shouxiang Hu

Applicant(s)/Patent Under
Reexamination
PARIKH ET AL.

Art Unit
2811

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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## FOREIGN PATENT DOCUMENTS

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	N					
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	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

HON-FATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Mohammad et al., Electronics Letters, March 14, 1996, V32, N6, pages 598-599				
	V	Binari et al., Electronics Letters, May 26, 1994, V30, N11, pages 909-911				
	w	Ng, Complete Guide to Semiconductor Devices, McGraw-Hill, Inc.,1995, pages 30-39)				
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.